

# Data analysis

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October 22, 2015

## MLE recap

- ▶  $X_1, \dots, X_n \sim f(x | \theta)$
- ▶  $L(X | \theta) = \prod_i f(x_i | \theta)$
- ▶ Ex: Poisson( $\lambda$ )
- ▶ Ex: Uniform( $0, \theta$ )
- ▶ Ex: Exponential( $\theta$ )

## Kullback–Leibler divergence

$$D_{KL}(P, Q) = \int_x p(x) \log \frac{p(x)}{q(x)} dx$$

- ▶ Non-negative
- ▶ Positive if the two distributions differ
- ▶  $\rightarrow$  *MLE* is consistent

## 10.4.1 Approximate MLE distribution

- ▶ iidrv random sample  $X_1, \dots, X_n \sim f(x | \theta)$
- ▶ MLE  $\hat{\theta}$
- ▶ Asymptotic distribution related to Fisher's Information matrix  $I(\theta)$  (multivariate case  $\theta \in \mathbb{R}^d$ ):

$$\sqrt{n}(\hat{\theta} - \theta) \xrightarrow{P} N(0, I^{-1}(\theta))$$

$$I_{ii}(\theta) = \text{Var} \left[ \frac{\partial \log f(X | \theta)}{\partial \theta_i} \right] = -\mathbb{E} \left[ \frac{\partial^2}{\partial \theta_i^2} \log f(X | \theta) \right]$$

$$\begin{aligned} I_{ij}(\theta) &= \text{Cov} \left[ \frac{\partial \log f(X | \theta)}{\partial \theta_i}, \frac{\partial \log f(X | \theta)}{\partial \theta_j} \right] \\ &= -\mathbb{E} \left[ \frac{\partial^2}{\partial \theta_i \partial \theta_j} \log f(X | \theta) \right] \end{aligned}$$

## Ch 8 Hypothesis testing

- ▶ A hypothesis is a statement about a population parameter
- ▶ Null hypothesis, i.e.  $H_0 : \theta = 0$
- ▶ Alternative hypothesis, i.e.  $H_1 : \theta \neq 0$
- ▶  $H_0$  is often much simpler than  $H_1$ , i.e. a vector subspace.
- ▶ Question: Can you reject  $H_0$ ?
  - ▶ Rejecting  $H_0$  does not mean accepting  $H_1$ .
  - ▶ You never “accept  $H_0$ ”.
- ▶ Test statistic critical region: ie. reject  $H_0$  if  $|\bar{X}| > 3$

## Rejecting does not mean rejecting

- ▶ Suppose there are 100 locations that might have oil at them
- ▶ Each location has a 4% chance of having oil
- ▶ Hypothesis test:
  - ▶  $H_0$  : oil vs  $H_1$  : no oil
  - ▶ Reject  $H_0$ .
  - ▶ but ..
- ▶ Cost of exploratory digging \$5M
- ▶ value of oil if found \$250M
- ▶  $\mathbb{E}[\text{benefit of drilling}] = -5 + 0.04 \times 250 = 5 > 0$

## p-values

- ▶ A statistic  $P = P(X)$  is a p-value if under  $H_0$ 
  - ▶  $P \sim \text{Uniform}(0, 1)$  or even if
  - ▶  $\forall t \in [0, 1], \mathbb{P}_{H_0}[P \leq t] \leq t$
- ▶ Rejecting  $H_0$  corresponds to small  $p$ -values.
- ▶ i.e. Reject  $H_0$  if  $p \leq 0.05$
- ▶ <https://xkcd.com/882/>
- ▶ Simulate multi-arm experiment with Uniforms

## Simple test

- ▶  $H_0 : \theta = \theta_0$  vs  $H_1 : \theta = \theta_1$
- ▶ Neither value may be correct, but which is better?
- ▶ Type I error:
  - ▶ Reject  $H_0$  under  $H_0$
  - ▶ Size of the test  $\alpha = \mathbb{P}_{H_0}(\text{Reject } H_0) \approx 0.05$
- ▶ Type II error:
  - ▶ Failing to reject  $H_0$  under  $H_1$  .
  - ▶ Power  $\beta = \mathbb{P}_{H_1}(\text{Reject } H_0)$   
[prob of not type II error-ing under  $H_1$ ]
- ▶ Possible critical region if  $\theta_0 < \theta_1$ :  
Reject  $H_0$  in  $C_\alpha = \{x : \hat{\theta}(x) > c_\alpha\}$
- ▶ Conflict between  $\alpha$  and  $\beta$  [experiment in R]
- ▶ Example:  $N$  coin tossed Bernoulli( $\theta$ ). Biased?
- ▶ Example: Normal known mean.



## Simple Likelihood ratio test

- ▶  $X_1, \dots, X_n \sim f(x | \theta)$
- ▶  $L(X | \theta) = \prod_i f(x_i | \theta)$
- ▶ For testing  $H_0 : \theta = \theta_0$  against  $H_1 : \theta = \theta_1$ , the likelihood ratio test statistic is:

$$\lambda(x) = \frac{L(\theta_0 | x)}{L(\theta_1 | x)}$$

- ▶ Critical region  $C_\alpha = \{x : \lambda(x) \leq c_\alpha\}$ .
- ▶ Choose  $c_\alpha$  such that  $\mathbb{P}_{\theta_0}[\lambda(x) \leq c_\alpha] = \alpha$
- ▶ Power  $\beta = \mathbb{P}_{\theta_1}[\lambda(x) < c_\alpha]$
- ▶ Example: Normal distribution  $N(\mu, 1)$ .  
 $H_0 : \mu = \mu_0$  vs  $H_1 : \mu \neq \mu_0$ .
- ▶ Example: Exponential distribution plus constant.  
 $X \sim \text{Exp}(1) + \theta$ .  
 $H_0 : \theta \leq \theta_0$  vs  $H_1 : \theta > \theta_0$ .
- ▶ Critical regions can be written in terms of sufficient statistics.

## The Neyman-Pearson lemma

- ▶  $X_1, \dots, X_n \sim f(x | \theta)$
- ▶ NP: The SLRT is as least as powerful as any other test of the same size.
- ▶ Proof:

SLRT critical region  $C_\alpha$

Another critical region  $C_1$  with same size  $\alpha$

$$\mathbb{P}_{\theta_0}(C_\alpha) = \mathbb{P}_{\theta_0}(C_1)$$

$$\mathbb{P}_{\theta_0}(C_\alpha \setminus C_1) = \mathbb{P}_{\theta_0}(C_1 \setminus C_\alpha)$$

$$\mathbb{P}_{\theta_1}(C_\alpha \setminus C_1) \geq \mathbb{P}_{\theta_1}(C_1 \setminus C_\alpha)$$

$$\mathbb{P}_{\theta_1}(C_\alpha) \geq \mathbb{P}_{\theta_1}(C_1)$$

## Simple null, composite alternative

- ▶  $H_0 : \theta = \theta_0$  vs  
 $H_1 : \theta \neq \theta_0$  or  $H_1 : \theta \geq \theta_0$  or  $H_1 : \theta \leq \theta_0$  or  $H_1 : \theta \in \mathbb{R}$
- ▶ Type I error:
  - ▶ Reject  $H_0$  under  $H_0$
  - ▶ Size of the test  $\alpha = \mathbb{P}_{H_0}(\text{Reject } H_0) \approx 0.05$
- ▶ Uniformly most powerful test:
  - ▶ A test is UMP of size  $\alpha$  if it has size  $\alpha$  and
  - ▶  $\forall \theta_1 \in H_1$ , the test's critical region is a most powerful test for testing  $H_0 : \theta = \theta_0$  vs  $H_1 : \theta \in \theta_1$ .
  - ▶ Generally possible for one sided test, not for two sided tests.

## Composite null, composite alternative LRT

- ▶  $H_0 : \theta \in \Theta_0$
- ▶  $H_1 : \theta \in \Theta_1$  or  $H_1 : \theta \in \Theta \setminus \Theta_0$  or just  $H_1 : \theta \in \Theta$
- ▶  $X_1, \dots, X_n \sim f(x | \theta)$
- ▶  $L(X | \theta) = \prod_i f(x_i | \theta)$
- ▶ Def 8.2.1 For testing  $H_0 : \theta \in \Theta_0$  against  $H_1 : \theta \in \Theta_1$ , the likelihood ratio test statistic is:

$$\lambda(x) = \frac{\sup_{\theta \in \Theta_0} L(\theta | x)}{\sup_{\theta \in \Theta_1} L(\theta | x)} = \frac{L(\hat{\theta}_0 | x)}{L(\hat{\theta}_1 | x)}$$

where  $\hat{\theta}_i$  is the MLE in  $\Theta_i$ ,  $i = 1, 2$ .

- ▶ Critical region  $\{x : \lambda(x) \leq c\}$ .

## Wilk's theorem

- ▶  $H_0 : \theta \in \Theta_0$
- ▶  $H_1 : \theta \in \Theta$
- ▶  $d = \dim(\Theta) - \dim(\Theta_0)$
- ▶  $-2 \log \lambda(x) \rightarrow \chi_d^2$  under some regularity conditions on  $f(x | \theta)$
- ▶ Ex:  $X_1, \dots, X_n \sim N(\theta, 1)$   
 $H_0 : \theta = 0$  vs  $H_1 : \theta \neq 0$ .  
 $-2 \log \lambda(x) = n\bar{x} \sim \chi_1^2$  exactly
- ▶ Ex: multinomial distribution  
6-sided die  
 $m \times n$  contingency table

